

1 **Supporting Information**

2 **Efficient Deep-Blue Crystalline OLED via Hot Exciton Nanoaggregate**

3 **Sensitizing TTA Emitter**

4

5 Hao Hu^{1,2}, Ping Lu³, Feng Zhu^{1,2*} and Donghang Yan^{1,2}

6 ¹State Key Laboratory of Polymer Science and Technology, Changchun Institute of Applied Chemistry,

7 Chinese Academy of Sciences; Changchun 130022, China.

8 ²School of Applied Chemistry and Engineering, University of Science and Technology of China, Hefei

9 230026, China.

10 ³State Key Laboratory of Supramolecular Structure and Materials, College of Chemistry, Jilin University,

11 2699 Qianjin Avenue, Changchun 130012, China

12 *Corresponding author. Email: zhufeng@ciac.ac.cn

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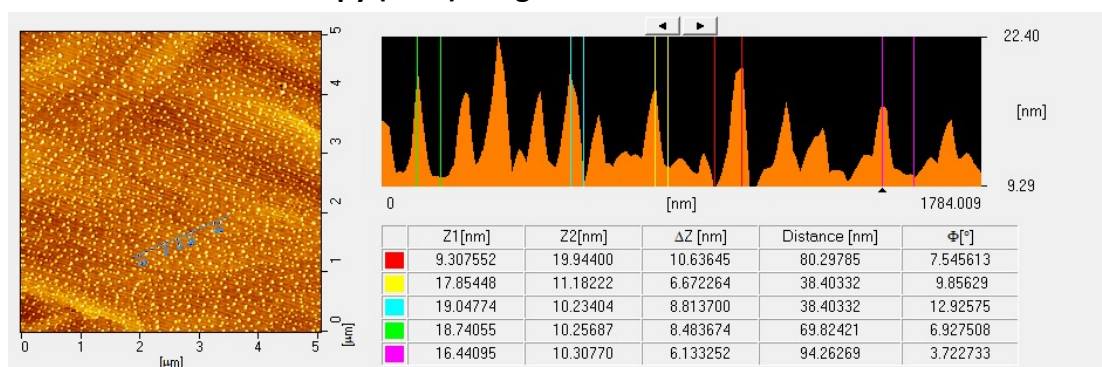
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23 **Fig. S1** Average height of nanoaggregates (6–11 nm).
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2. EL performance of Crystalline OLED

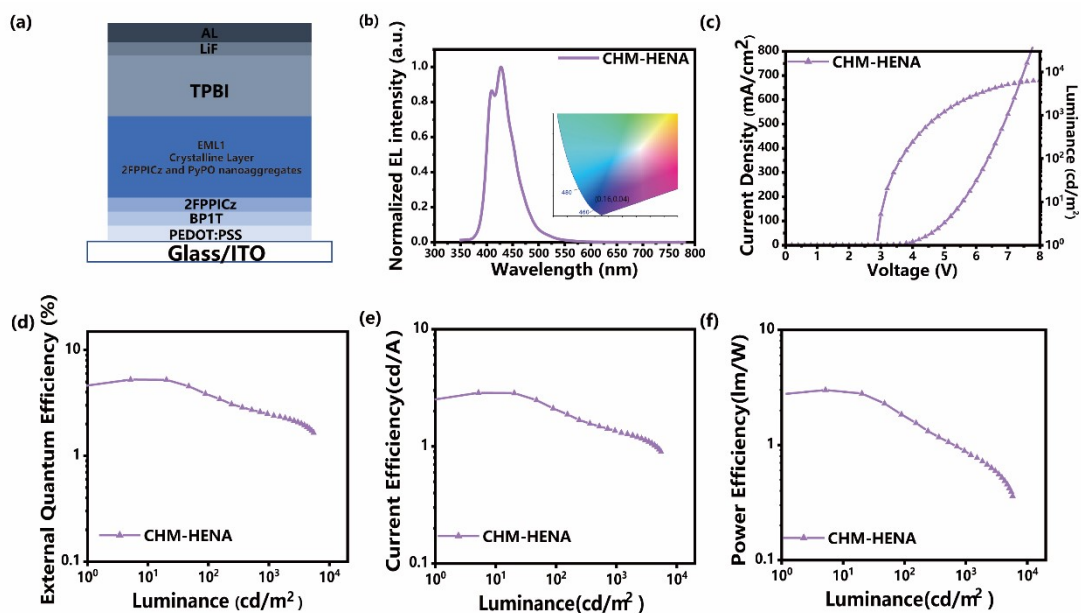


Fig. S2 Device Performance of CHM-HENA OLED. (a) The device structure of CHM-HENA OLED. (b) EL spectrum at luminance of 1000cd/m² and the corresponding CIE of the device. (c) Voltage-dependent current density and luminance. (d) Luminance-dependent external quantum efficiency characteristics. (e) Luminance-dependent current efficiency characteristics. (f) Luminance-dependent power efficiency characteristics.

3. Comparisons of CHM-HENA-TTAD OLED with amorphous high EQE OLEDs

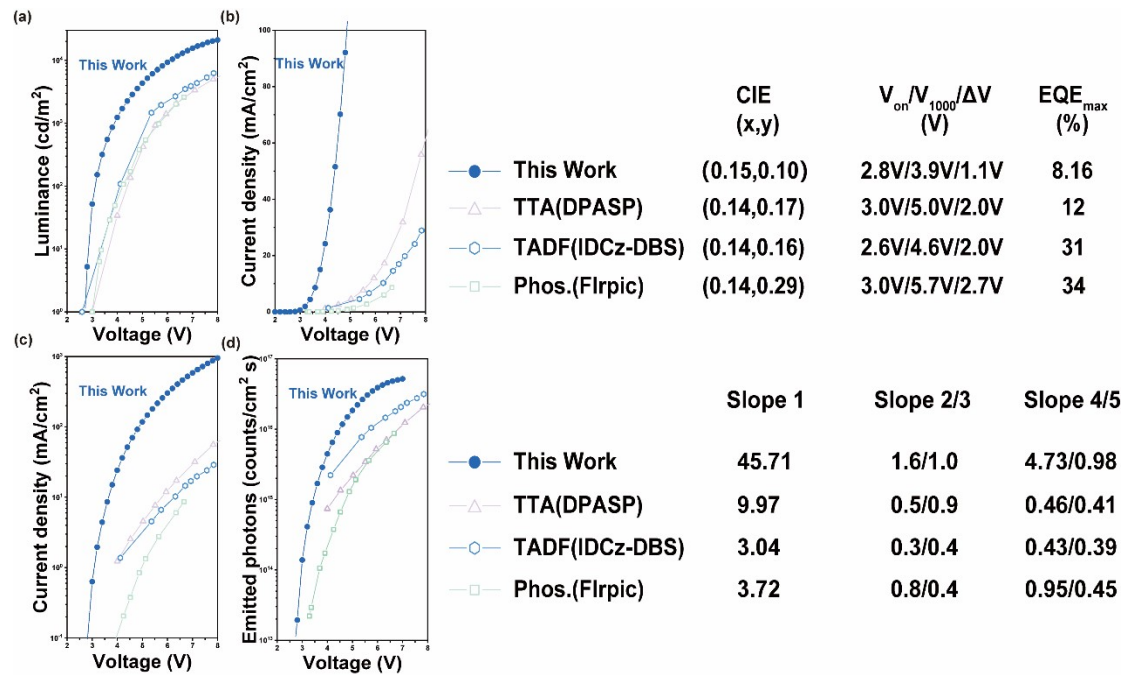


Fig. S3 Comparisons of CHM-HENA-TTAD OLED with amorphous high EQE OLEDs. (a) Comparison of voltage (V)-dependent luminance (L) curves. (b) Comparison of voltage (V)-dependent current density (J) characteristics. (c) Comparison of voltage (V) with dependent semi-log current density (J) characteristics. (d) Comparison of voltage (V) with semi-log emitted photons (N) between CHM-HENA-TTAD OLED and reported high EQE OLEDs based on TTA, TADF, phosphorescent materials. Reference data for comparison are taken from the relevant literature.

47 **4. Summary of PLQYs of thin films**

48 **Table S1** Summary of PLQYs of films.

The film	Φ_{pl}
2FPPI Cz neat crystalline film	0.29 ^{S1}
PyPO neat film	0.76 ^{S2}
DPASP neat film	0.99 ^{S3}
CHM-HENA film	0.69
CHM-HENA-TTAD film	0.85

5. Comparison of CHM-HENA-TTAD OLED with high-EQE amorphous OLEDs

Table S2 Comparison of CHM-HENA-TTAD OLED with high-EQE amorphous OLEDs.

Device	CE/PE/EQE _{max} ^{a)} [cd A ⁻¹ /lm W ⁻¹ /%]	Input power ^{b)} [mW cm ⁻²]	differential resistance ^{b)} [kΩ·cm ²]	Joule heat ^{b)} [mW cm ⁻²]	Ratio ^{b)} [%]	Ref.
CHM-HENA-TTAD	8.20/8.59/8.16	70.20	0.020	7.0	10.06	This work
DPASP	18.5/16.5/12.0	42.15	0.100	7.2	17.00	^{S3}
IDCz-DBS	-/29.8/31.1	24.32	0.329	5.2	21.19	^{S4}
Flrpic	61.7/56.2/34.6	15.58	0.269	2.0	13.10	^{S5}

^{a)} Maximum CE, PE and EQE values; ^{b)} The areal Joule heat loss of the CHM-HENA-TTAD compared with that of other typical amorphous blue-emission OLEDs at a luminance of approximately 1000 cd/m². All reference data for comparison are extracted from the corresponding literature.

57 **6. References**

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